

50 V, 170 mA dual P-channel Trench MOSFET Rev. 1 — 19 May 2011

Product data sheet

Product profile 1.

1.1 General description

Dual P-channel enhancement mode Field-Effect Transistor (FET) in an ultra small and flat lead SOT666 Surface-Mounted Device (SMD) plastic package using Trench MOSFET technology.

1.2 Features and benefits

- Logic-level compatible
- Very fast switching
- Trench MOSFET technology

1.3 Applications

- Relay driver
- High-speed line driver

- ESD protection up to 1 kV
- AEC-Q101 qualified
- High-side loadswitch
- Switching circuits

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per transi	stor					
V _{DS}	drain-source voltage	T _j = 25 °C	-	-	-50	V
V _{GS}	gate-source voltage		-20	-	20	V
I _D	drain current	V_{GS} = -10 V; T_{amb} = 25 °C	<u>[1]</u> _	-	-170	mA
Static cha	racteristics (per transiste	or)				
R _{DSon}	drain-source on-state resistance	V_{GS} = -10 V; I _D = -100 mA; T _j = 25 °C	-	4.5	7.5	Ω

[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 1 cm².



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2. Pinning information

Table 2.	Pinning	j information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S1	source 1		54 52
2	G1	gate 1		
3	D2	drain 2		
4	S2	source 2	0	G1 + G2
5	G2	gate 2		
6	D1	drain 1	SOT666 (SOT666)	S1 S2 sym147

3. Ordering information

Table 3.	Ordering in	formation		
Type num	ber	Package		
		Name	Description	Version
BSS84AK\	/	SOT666	plastic surface-mounted package; 6 leads	SOT666

4. Marking

Table 4. Marking codes	
Type number	Marking code ^[1]
BSS84AKV	EG

[1] % = placeholder for manufacturing site code

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
Per trans	istor					
V _{DS}	drain-source voltage	T _j = 25 °C		-	-50	V
V _{GS}	gate-source voltage			-20	20	V
I _D	drain current	V_{GS} = -10 V; T_{amb} = 25 °C	<u>[1]</u>	-	-170	mA
		V_{GS} = -10 V; T_{amb} = 100 °C	<u>[1]</u>	-	-110	mA
I _{DM}	peak drain current	T_{amb} = 25 °C; single pulse; $t_p \le 10 \ \mu s$		-	-0.7	А
P _{tot}	total power dissipation	T _{amb} = 25 °C	[2]	-	330	mW
			[1]	-	390	mW
		T _{sp} = 25 °C		-	1090	mW
Per devic	e					
P _{tot}	total power dissipation	T _{amb} = 25 °C	[2]	-	500	mW
Tj	junction temperature			-55	150	°C
T _{amb}	ambient temperature			-55	150	°C
T _{stg}	storage temperature			-65	150	°C
Source-d	rain diode					
I _S	source current	T _{amb} = 25 °C	<u>[1]</u>	-	-170	mA
ESD max	imum rating					
V _{ESD}	electrostatic discharge voltage	НВМ	[3]	-	1000	V

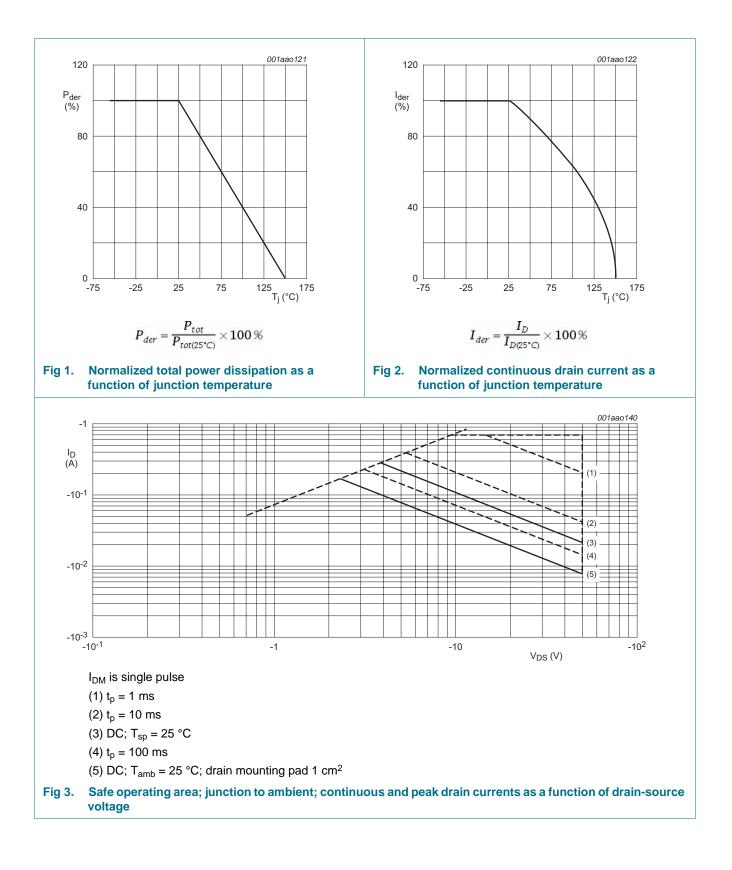
[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 1 cm².

[2] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

[3] Measured between all pins.

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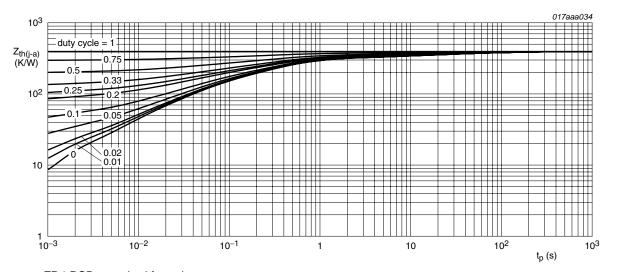
6. Thermal characteristics

Table 6. I	nermal characteristics						
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Per device							
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	<u>[1]</u>	-	-	250	K/W
Per transist	or						
R _{th(j-a)}	thermal resistance from junction to	in free air	<u>[1]</u>	-	330	380	K/W
	ambient		[2]	-	280	320	K/W
R _{th(j-sp)}	thermal resistance from junction to sold point	er		-	-	115	K/W

Table 6. Thermal characteristics

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 1 cm².

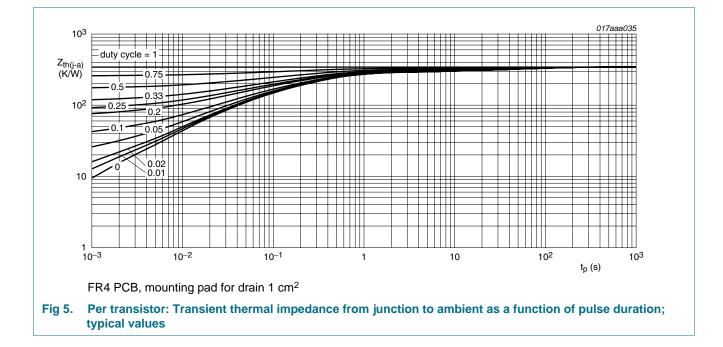


FR4 PCB, standard footprint

Fig 4. Per transistor: Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

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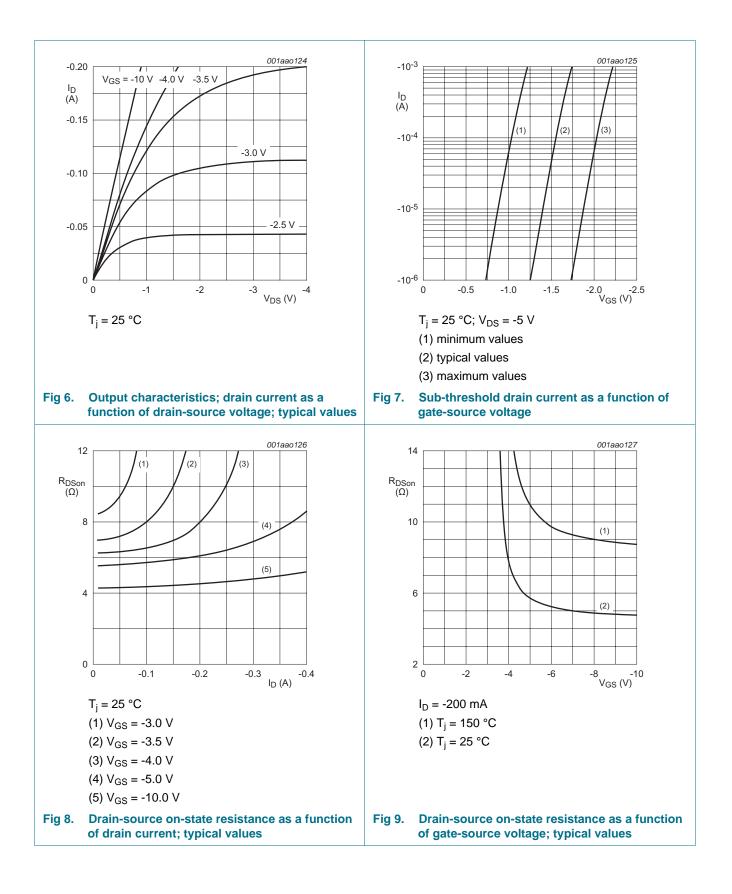


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7. Characteristics

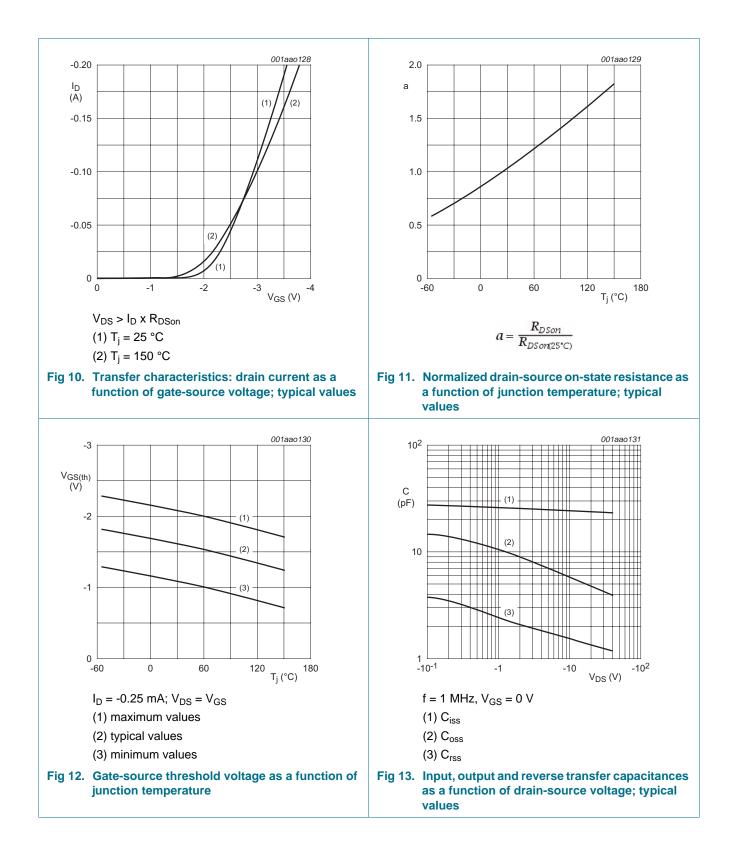
Table 7.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
Static cha	racteristics (per transistor)					
V _{(BR)DSS}	drain-source breakdown voltage	$I_D = -10 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = 25 \ ^{\circ}C$	-50	-	-	V
V _{GSth}	gate-source threshold voltage	$I_D = -250 \ \mu A; \ V_{DS} = V_{GS}; \ T_j = 25 \ ^{\circ}C$	-1.1	-1.6	-2.1	V
I _{DSS}	drain leakage current	$V_{DS} = -50 \text{ V}; V_{GS} = 0 \text{ V}; \text{ T}_{j} = 25 \text{ °C}$	-	-	-1	μA
		V_{DS} = -50 V; V_{GS} = 0 V; T_j = 150 °C	-	-	-2	μA
I _{GSS}	gate leakage current	V_{GS} = -20 V; V_{DS} = 0 V; T_j = 25 °C	-	-	-10	μA
		$V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{V}; \text{T}_{j} = 25 ^{\circ}\text{C}$	-	-	-10	μA
R _{DSon}	drain-source on-state	V_{GS} = -10 V; I _D = -100 mA; T _j = 25 °C	-	4.5	7.5	Ω
	resistance	V_{GS} = -10 V; I_D = -100 mA; T_j = 150 °C	-	8	13.5	Ω
		V_{GS} = -5 V; I_D = -100 mA; T_j = 25 °C	-	5.7	8.5	Ω
9 _{fs}	forward transconductance	V_{DS} = -10 V; I _D = -100 mA; T _j = 25 °C	-	150	-	mS
Dynamic	characteristics (per transistor)				
Q _{G(tot)}	total gate charge	V_{DS} = -25 V; I_{D} = -200 mA; V_{GS} = -5 V;	-	0.26	0.35	nC
Q _{GS}	gate-source charge	T _j = 25 °C	-	0.12	-	nC
Q_{GD}	gate-drain charge		-	0.09	-	nC
C _{iss}	input capacitance	$V_{DS} = -25 V$; f = 1 MHz; $V_{GS} = 0 V$;	-	24	36	pF
C _{oss}	output capacitance	$T_j = 25 \ ^{\circ}C$	-	4.5	-	pF
C _{rss}	reverse transfer capacitance		-	1.3	-	pF
t _{d(on)}	turn-on delay time	V_{DS} = -30 V; R_L = 250 Ω ; V_{GS} = -10 V;	-	13	26	ns
t _r	rise time	$R_{G(ext)} = 6 \Omega; T_j = 25 °C$	-	11	-	ns
t _{d(off)}	turn-off delay time		-	48	96	ns
t _f	fall time		-	25	-	ns
Source-di	rain diode (per transistor)					
V _{SD}	source-drain voltage	I _S = -115 mA; V _{GS} = 0 V; T _i = 25 °C	-0.48	-0.85	-1.2	V

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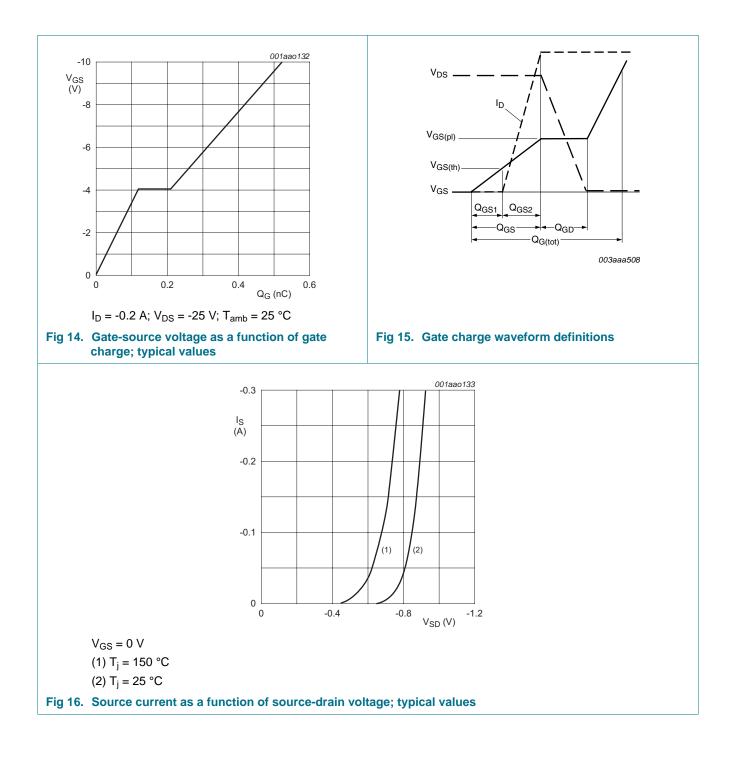
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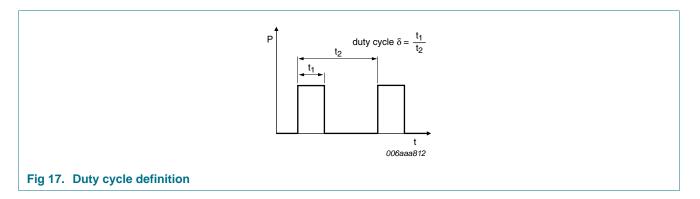


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8. Test information



8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard Q101 - Stress test qualification for discrete semiconductors, and is suitable for use in automotive applications.

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9. Package outline

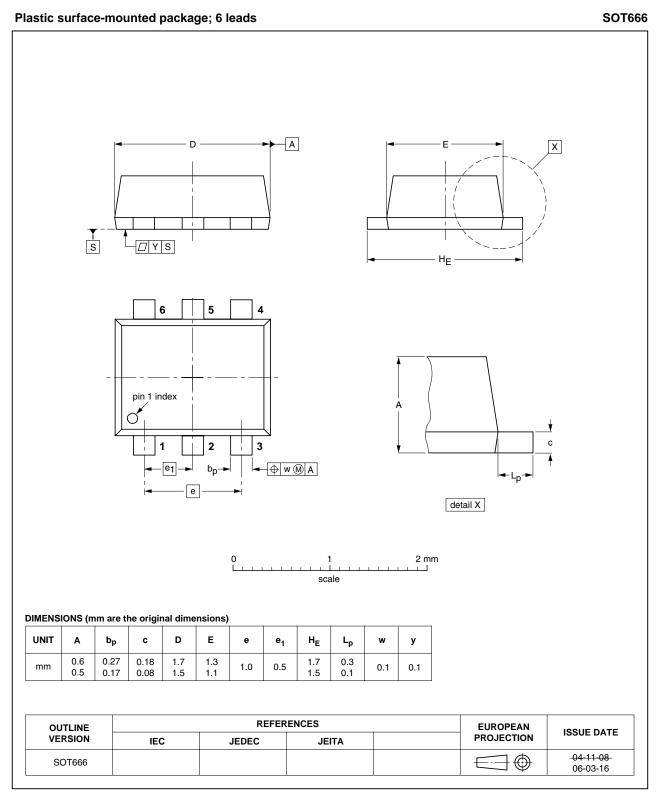
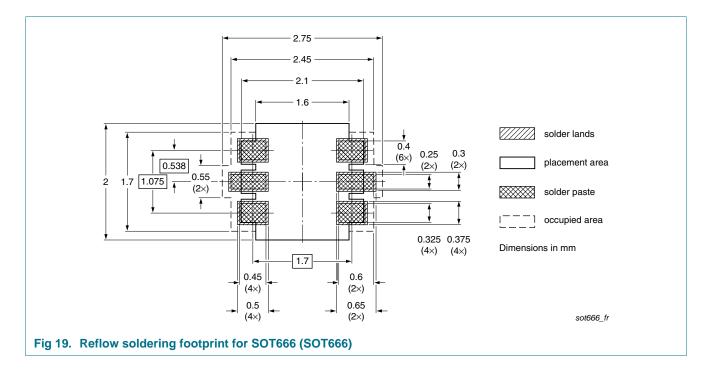


Fig 18. Package outline SOT666 (SOT666)

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10. Soldering



11. Revision history

Table 8.	Revision history						
Document	ID	Release date	Data sheet status	Change notice	Supersedes		
BSS84AKV	v.1	20110519	Product data sheet	-	-		

12. Legal information

12.1 Data sheet status

Document status [1] [2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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